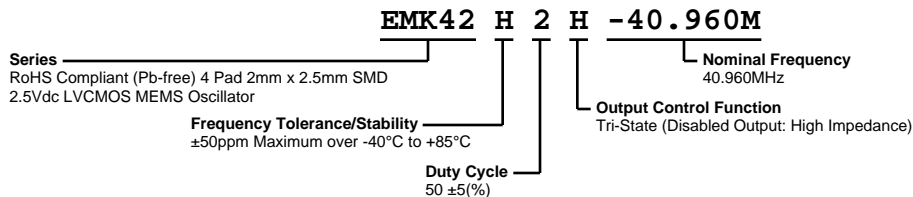


# EMK42H2H-40.960M



**ECLIPTEK**  
CORPORATION



## ELECTRICAL SPECIFICATIONS

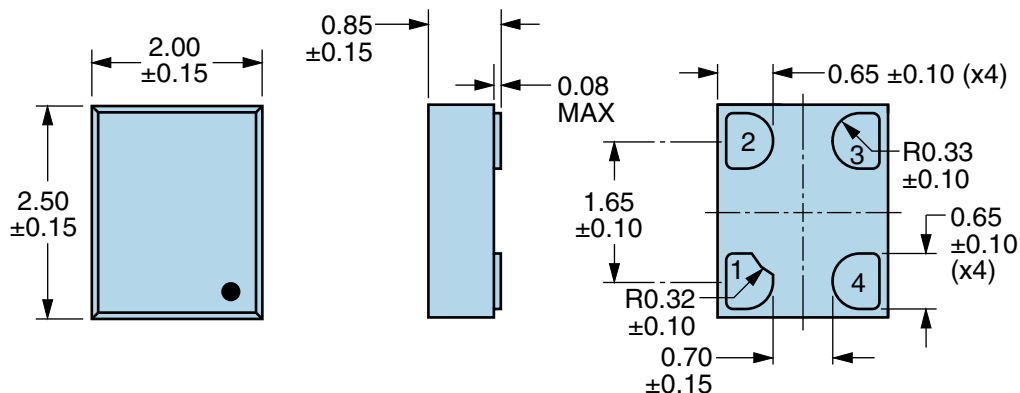
|                                 |  |
|---------------------------------|--|
| Nominal Frequency               | 40.960MHz  |
| Frequency Tolerance/Stability   | ±50ppm Maximum over -40°C to +85°C (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, 260°C Reflow, Shock, and Vibration) |
| Aging at 25°C                   | ±1ppm Maximum First Year   |
| Operating Temperature Range     | -40°C to +85°C   |
| Supply Voltage                  | 2.5Vdc ±5%   |
| Input Current                   | 20mA Maximum   |
| Output Voltage Logic High (Voh) | 90% of Vdd Minimum (IOH=-8mA)  |
| Output Voltage Logic Low (Vol)  | 10% of Vdd Maximum (IOL=+8mA)  |
| Rise/Fall Time                  | 2nSec Maximum (Measured from 20% to 80% of waveform)   |
| Duty Cycle                      | 50 ±5(%) (Measured at 50% of waveform)   |
| Load Drive Capability           | 15pF Maximum   |
| Output Logic Type               | CMOS   |
| Output Control Function         | Tri-State (Disabled Output: High Impedance)  |
| Output Control Input Voltage    | +0.7Vdd Minimum or No Connect to Enable Output, +0.3Vdd Maximum to Disable Output  |
| Peak to Peak Jitter (tPK)       | 250pSec Maximum, 100pSec Typical   |
| Start Up Time                   | 50mSec Maximum   |
| Storage Temperature Range       | -55°C to +125°C  |

## ENVIRONMENTAL & MECHANICAL SPECIFICATIONS

|                              |   |
|------------------------------|---|
| ESD Susceptibility           | MIL-STD-883, Method 3015, Class 2, HBM 2000V              |
| Flammability                 | UL94-V0   |
| Mechanical Shock             | MIL-STD-883, Method 2002, Condition G, 30,000G            |
| Moisture Resistance          | MIL-STD-883, Method 1004                                  |
| Moisture Sensitivity Level   | J-STD-020, MSL 1  |
| Resistance to Soldering Heat | MIL-STD-202, Method 210, Condition K                      |
| Resistance to Solvents       | MIL-STD-202, Method 215                                   |
| Solderability                | MIL-STD-883, Method 2003 (Pads on Bottom of Package Only) |
| Temperature Cycling          | MIL-STD-883, Method 1010, Condition B                     |
| Thermal Shock                | MIL-STD-883, Method 1011, Condition B                     |
| Vibration                    | MIL-STD-883, Method 2007, Condition A, 20G                |

# EMK42H2H-40.960M

## MECHANICAL DIMENSIONS (all dimensions in millimeters)

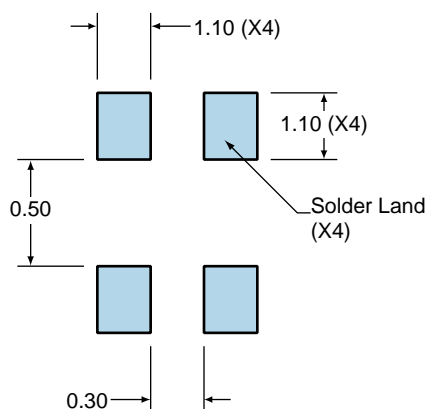


| PIN | CONNECTION     |
|-----|----------------|
| 1   | Tri-State      |
| 2   | Ground         |
| 3   | Output         |
| 4   | Supply Voltage |

| LINE | MARKING   |
|------|---|
| 1    | XXXX or XXXXX<br>XXXX or XXXXX=Ecliptek<br>Manufacturing Lot Code |

## Suggested Solder Pad Layout

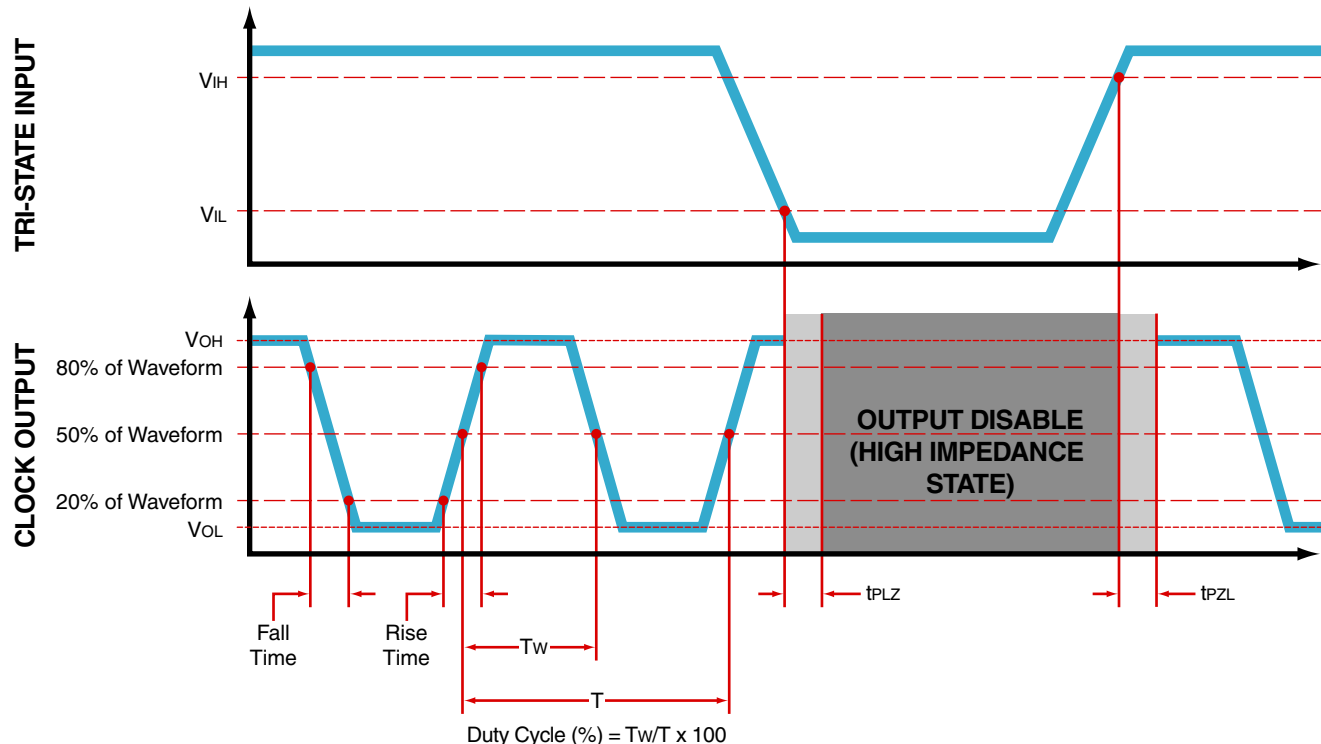
All Dimensions in Millimeters



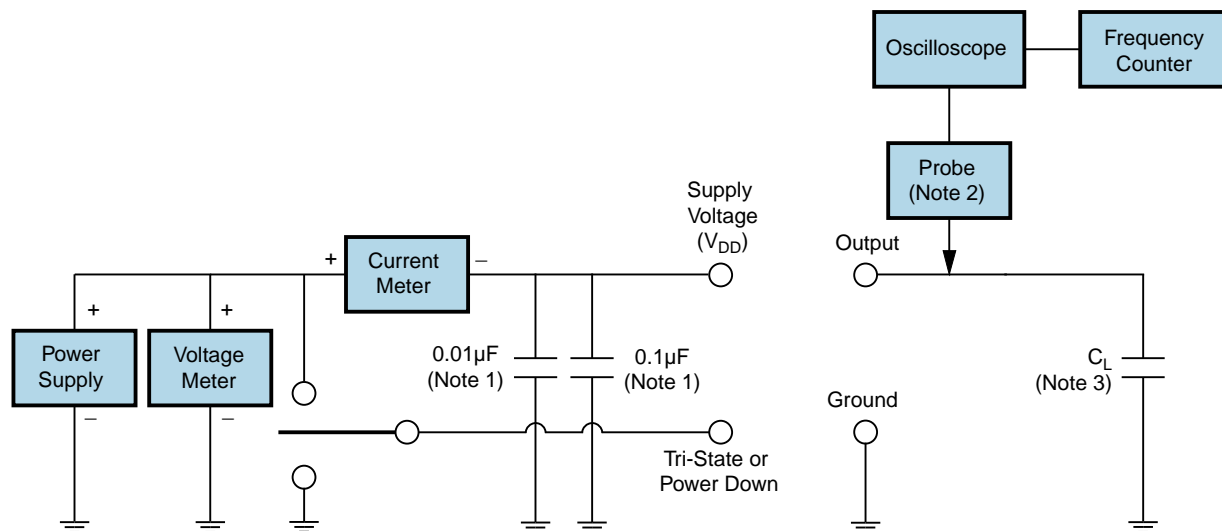
All Tolerances are  $\pm 0.1$

# EMK42H2H-40.960M

## OUTPUT WAVEFORM & TIMING DIAGRAM



## Test Circuit for CMOS Output

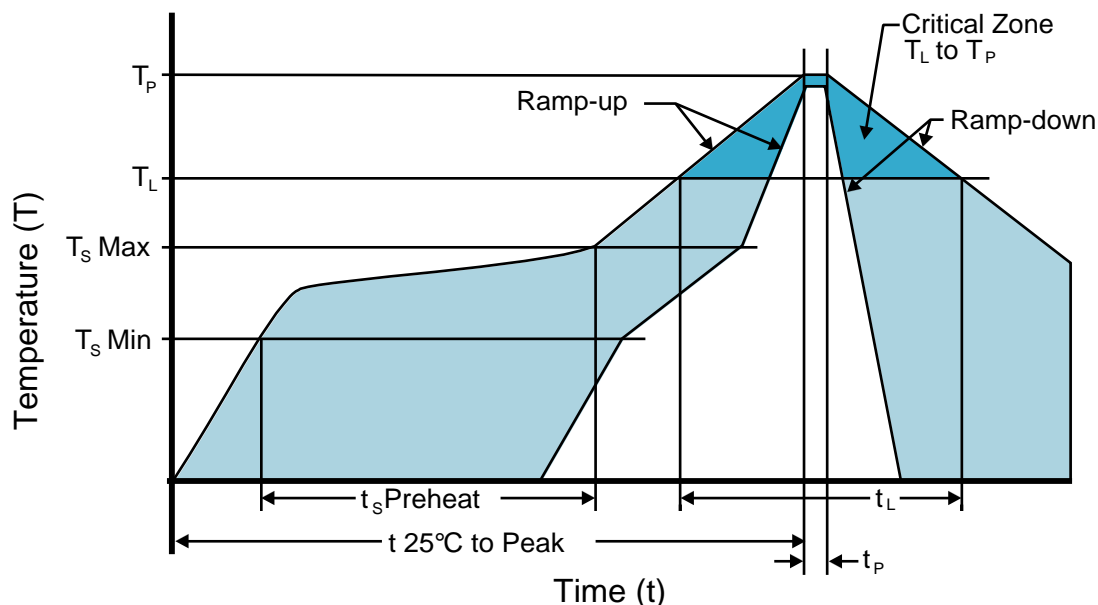


Note 1: An external 0.1  $\mu\text{F}$  low frequency tantalum bypass capacitor in parallel with a 0.01  $\mu\text{F}$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.

## Recommended Solder Reflow Methods



### High Temperature Infrared/Convection

**$T_s$  MAX to  $T_L$  (Ramp-up Rate)** 3°C/second Maximum

#### Preheat

- Temperature Minimum ( $T_s$  MIN) 150°C  
 - Temperature Typical ( $T_s$  TYP) 175°C  
 - Temperature Maximum ( $T_s$  MAX) 200°C  
 - Time ( $t_s$  MIN) 60 - 180 Seconds

**Ramp-up Rate ( $T_L$  to  $T_P$ )** 3°C/second Maximum

#### Time Maintained Above:

- Temperature ( $T_L$ ) 217°C  
 - Time ( $t_L$ ) 60 - 150 Seconds

**Peak Temperature ( $T_P$ )** 260°C Maximum for 10 Seconds Maximum

**Target Peak Temperature ( $T_P$  Target)** 250°C +0/-5°C

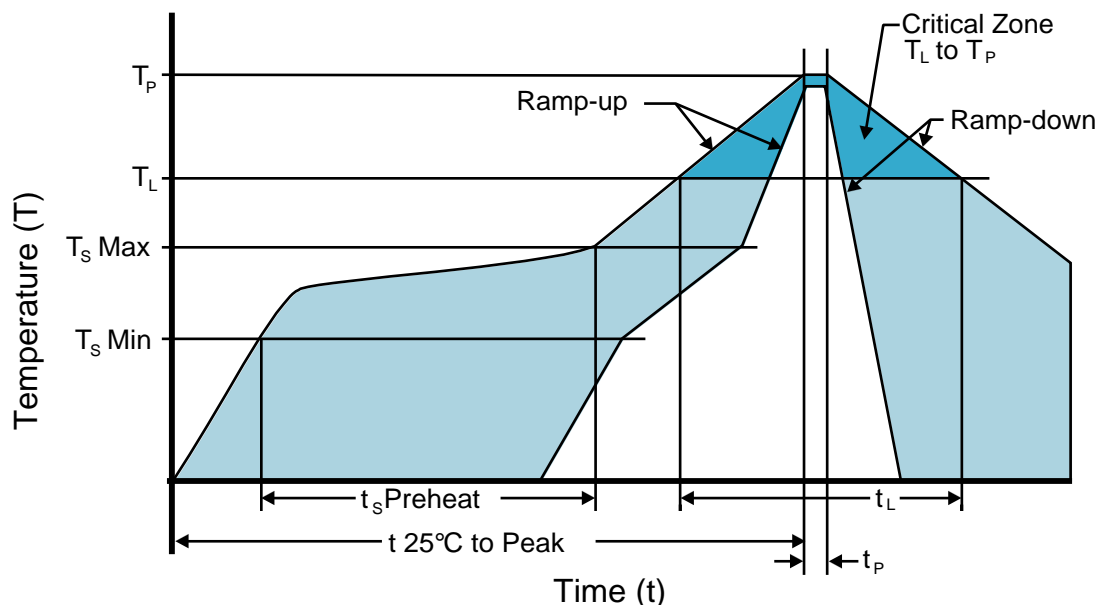
**Time within 5°C of actual peak ( $t_p$ )** 20 - 40 seconds

**Ramp-down Rate** 6°C/second Maximum

**Time 25°C to Peak Temperature ( $t$ )** 8 minutes Maximum

**Moisture Sensitivity Level** Level 1

## Recommended Solder Reflow Methods



### Low Temperature Infrared/Convection 240°C

$T_S$  MAX to  $T_L$  (Ramp-up Rate) 5°C/second Maximum

#### Preheat

- Temperature Minimum ( $T_S$  MIN) N/A
- Temperature Typical ( $T_S$  TYP) 150°C
- Temperature Maximum ( $T_S$  MAX) N/A
- Time ( $t_s$  MIN) 60 - 120 Seconds

Ramp-up Rate ( $T_L$  to  $T_P$ ) 5°C/second Maximum

#### Time Maintained Above:

- Temperature ( $T_L$ ) 150°C
- Time ( $t_L$ ) 200 Seconds Maximum

Peak Temperature ( $T_P$ ) 240°C Maximum

Target Peak Temperature ( $T_P$  Target) 240°C Maximum 1 Time / 230°C Maximum 2 Times

Time within 5°C of actual peak ( $t_p$ ) 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time

Ramp-down Rate 5°C/second Maximum

Time 25°C to Peak Temperature (t) N/A

Moisture Sensitivity Level Level 1

### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

### High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.